PSMN020-30MLC

N-channel 30 V 18.1 m Ω logic level MOSFET in LFPAK33 using TrenchMOS Technology

4 September 2012

Product data sheet

1. Product profile

1.1 General description

Logic level enhancement mode N-channel MOSFET in LFPAK33 package. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- Low parasitic inductance and resistance
- Optimised for 4.5V Gate drive utilising Superjunction technology
- Ultra low QG, QGD, and QOSS for high system efficiencies at low and high loads

1.3 Applications

- DC-to-DC converters
- Load switching
- Synchronous buck regulator

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j = 25 °C	-	-	30	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; <u>Fig. 1</u>	-	-	31.8	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	-	33	W
Tj	junction temperature		-55	-	175	°C
Static char	acteristics			'	'	,
R _{DSon}	drain-source on-state resistance	V_{GS} = 4.5 V; I_D = 5 A; T_j = 25 °C; Fig. 10	-	20.5	27	mΩ
		V _{GS} = 10 V; I _D = 5 A; T _j = 25 °C; <u>Fig. 10</u>	-	14.7	18.1	mΩ
Dynamic c	haracteristics					
Q_{GD}	gate-drain charge	V _{GS} = 4.5 V; I _D = 5 A; V _{DS} = 15 V; Fig. 12; Fig. 13	-	1.7	-	nC
Q _{G(tot)}	total gate charge	V _{GS} = 4.5 V; I _D = 5 A; V _{DS} = 15 V; Fig. 12; Fig. 13	-	4.6	-	nC





2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		D I
2	S	source		
3	S	source		G (F) 44
4	G	gate		mbb076 S
mb	D	mounting base; connected to drain	LFPAK33 (SOT1210)	

3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
PSMN020-30MLC	LFPAK33	Plastic single ended surface mounted package (LFPAK33); 4 leads	SOT1210			

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j = 25 °C	-	30	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 1</u>	-	31.8	Α
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 1</u>	-	22.5	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$; Fig. 4	-	127	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	33	W
T _{stg}	storage temperature		-55	175	°C
T _j	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
V _{ESD}	electrostatic discharge voltage	MM (JEDEC JESD22-A115)	130	-	V
Source-dra	in diode				
I _S	source current	T _{mb} = 25 °C	-	27.4	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	127	Α

Symbol	Parameter	Conditions	Min	Max	Unit
Avalanche rug	gedness				
E _{DS(AL)} S	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 31 A; $V_{sup} \le$ 30 V; R_{GS} = 50 Ω; unclamped; Fig. 3	-	7.7	mJ

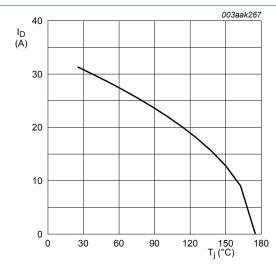


Fig. 1. Continuous drain current as a function of mounting base temperature

$$V_{GS} \ge 10V$$

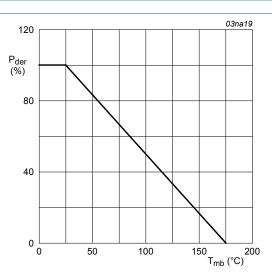


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

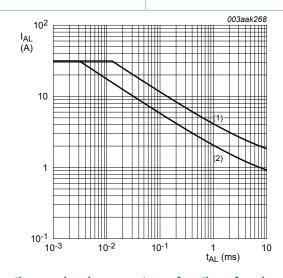
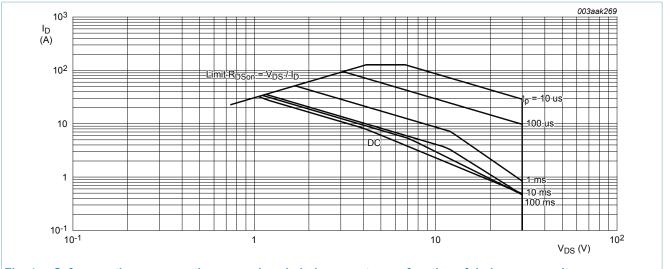


Fig. 3. Single pulse avalanche rating; avalanche current as a function of avalanche time

(1)
$$T_{j (init)} = 25^{\circ}C$$
; (2) $T_{j (init)} = 100^{\circ}C$



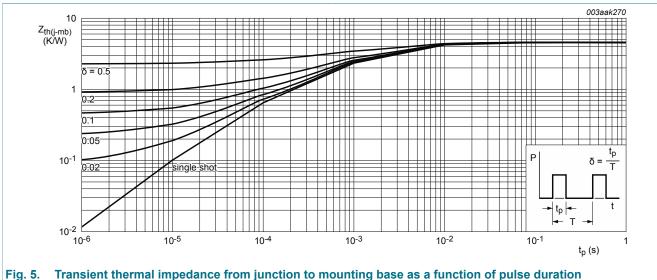
Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25^{\circ}C$; I_{DM} is a single pulse

Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 5	-	4.32	4.56	K/W



6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static charac	cteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 13.5 A; V_{GS} = 0 V; $T_{j(init)}$ = 25 °C; $t_p \le 50 \ \mu s$	34	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C	1.05	1.62	1.95	V
$\Delta V_{GS(th)}/\Delta T$	gate-source threshold voltage variation with temperature		-	-3.5	-	mV/k
I _{DSS}	drain leakage current	V _{DS} = 30 V; V _{GS} = 0 V; T _j = 25 °C	-	-	1	μA
		V _{DS} = 30 V; V _{GS} = 0 V; T _j = 150 °C	-	-	100	μΑ
I _{GSS} gate leakage curren	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	-	100	nA
		V _{GS} = -16 V; V _{DS} = 0 V; T _j = 25 °C	-	-	100	nA
R _{DSon} drain-source on-state resistance		$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; T_j = 25 ^{\circ}\text{C};$ Fig. 10	-	20.5	27	mΩ
		V _{GS} = 4.5 V; I _D = 5 A; T _j = 150 °C; Fig. 10; Fig. 11	-	-	43.2	mΩ
		V_{GS} = 10 V; I_D = 5 A; T_j = 25 °C; <u>Fig. 10</u>	-	14.7	18.1	mΩ
	V _{GS} = 10 V; I _D = 5 A; T _j = 150 °C; Fig. 10; Fig. 11	-	-	29	mΩ	
R _G	gate resistance	f = 1 MHz	0.68	1.37	2.74	Ω
Dynamic cha	aracteristics					
Q _{G(tot)}	total gate charge	I _D = 5 A; V _{DS} = 15 V; V _{GS} = 10 V; Fig. 12; Fig. 13	-	9.5	-	nC
		I _D = 5 A; V _{DS} = 15 V; V _{GS} = 4.5 V; Fig. 12; Fig. 13	-	4.6	-	nC
		I _D = 0 A; V _{DS} = 0 V; V _{GS} = 10 V	-	8.4	-	nC
Q _{GS}	gate-source charge	I _D = 5 A; V _{DS} = 15 V; V _{GS} = 4.5 V;	-	1	-	nC
Q _{GS(th)}	pre-threshold gate- source charge	Fig. 12; Fig. 13	-	0.3	-	nC
Q _{GS(th-pl)}	post-threshold gate- source charge		-	0.7	-	nC
Q_{GD}	gate-drain charge		-	1.7	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	I _D = 5 A; V _{DS} = 15 V; <u>Fig. 12</u> ; <u>Fig. 13</u>	-	2.4	-	V

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C _{iss}	input capacitance	V _{DS} = 15 V; V _{GS} = 0 V; f = 1 MHz;	-	430	-	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 14</u>	-	120	-	pF
C _{rss}	reverse transfer capacitance		-	70	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; R_L = 3 \Omega; V_{GS} = 4.5 \text{ V};$	-	6.1	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$	-	7.2	-	ns
t _{d(off)}	turn-off delay time		-	10.1	-	ns
t _f	fall time		-	5.1	-	ns
Q _{oss}	output charge	$V_{GS} = 0 \text{ V}; V_{DS} = 15 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 ^{\circ}\text{C}$	-	2.3	-	nC
Source-dra	ain diode					
V_{SD}	source-drain voltage	I _S = 5 A; V _{GS} = 0 V; T _j = 25 °C; <u>Fig. 15</u>	-	0.89	1.1	V
t _{rr}	reverse recovery time	$I_S = 5 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	13.5	-	ns
Q _r	recovered charge	V _{DS} = 15 V	-	5.1	-	nC
t _a	reverse recovery rise time	$V_{GS} = 0 \text{ V; } I_S = 5 \text{ A; } dI_S/dt = -100 \text{ A/}\mu\text{s;}$ $V_{DS} = 15 \text{ V; } \underline{\text{Fig. 16}}$	-	6.3	-	ns
t _b	reverse recovery fall time		-	7.2	-	ns

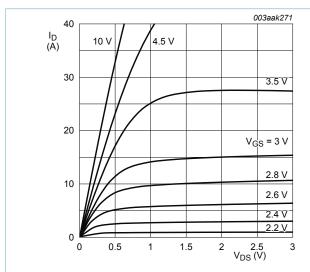


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

 $T_j = 25$ °C

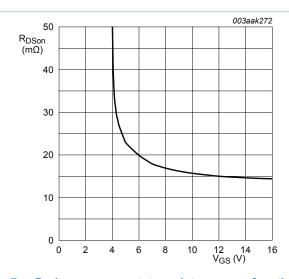


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_j = 25^{\circ}C; I_D = 10A$

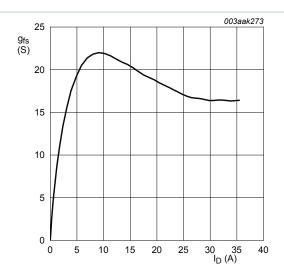


Fig. 8. Forward transconductance as a function of drain current; typical values

$$T_j = 25^{\circ}C; \ V_{DS} = 10V$$

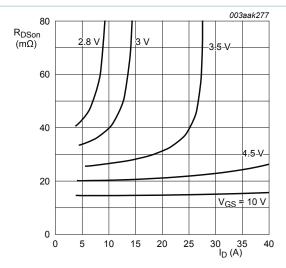


Fig. 10. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25$$
° C

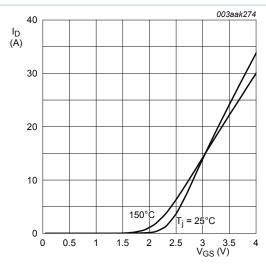


Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values

$$V_{DS} = 10V$$

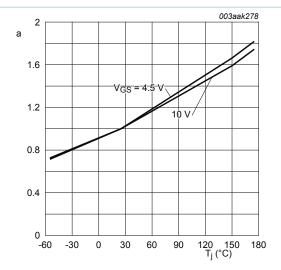


Fig. 11. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon}(25^{\circ}C)}$$

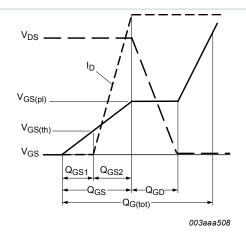


Fig. 12. Gate charge waveform definitions

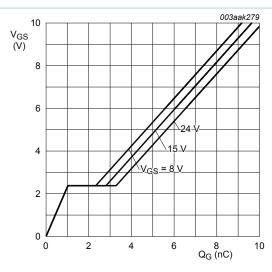


Fig. 13. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25^{\circ}C; I_D = 10A$$

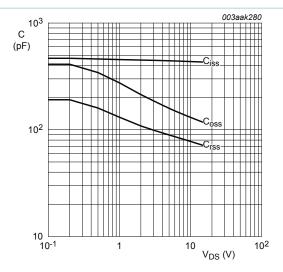


Fig. 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = \mathbf{0}V; \ f = \mathbf{1}MHz$$

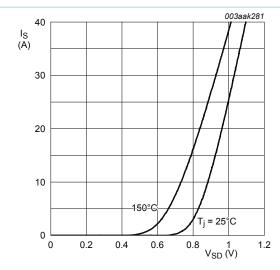
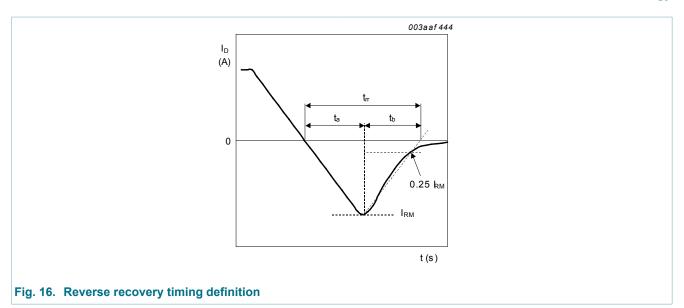
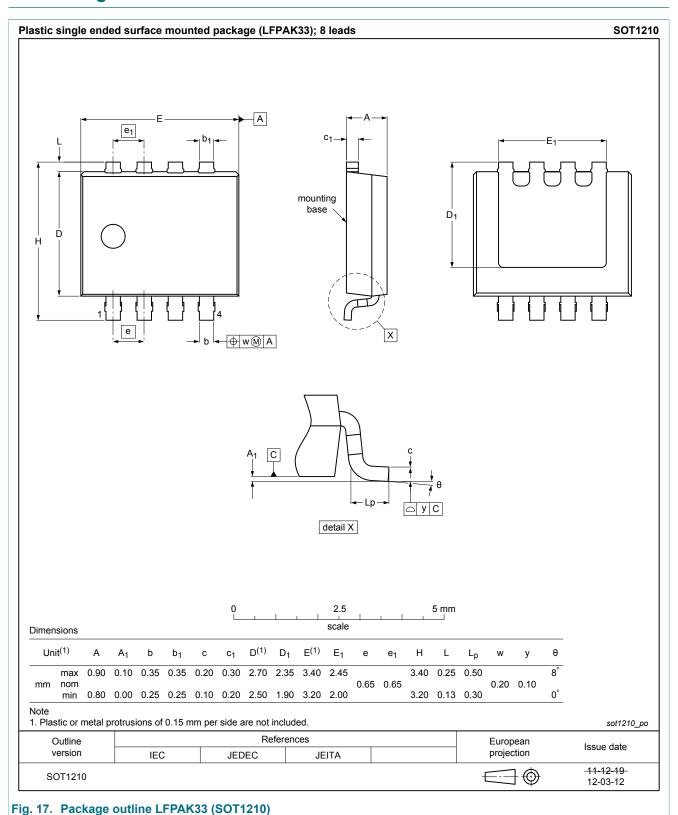


Fig. 15. Source current as a function of source-drain voltage; typical values

$$V_{GS} = 0V$$



7. Package outline



8. Legal information

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Document status [1][2]	Product status [3]	Definition
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